



October 2008



# FSB50825US

## Smart Power Module (SPM<sup>®</sup>)

### Features

- 250V 8A 3-phase FRFET inverter including high voltage integrated circuit (HVIC)
- 3 divided negative dc-link terminals for inverter current sensing applications
- HVIC for gate driving and undervoltage protection
- 3/5V CMOS/TTL compatible, active-high interface
- Optimized for low electromagnetic interference
- Isolation voltage rating of 1500Vrms for 1min.
- Surface mounted device package
- Moisture Sensitive Level (MSL) 3

### General Description

FSB50825US is a tiny smart power module (SPM<sup>®</sup>) based on FRFET technology as a compact inverter solution for small power motor drive applications such as fan motors and water suppliers. It is composed of 6 fast-recovery MOSFET (FRFET), and 3 half-bridge HVICs for FRFET gate driving. FSB50825US provides low electromagnetic interference (EMI) characteristics with optimized switching speed. Moreover, since it employs FRFET as a power switch, it has much better ruggedness and larger safe operation area (SOA) than that of an IGBT-based power module or one-chip solution. The package is optimized for the thermal performance and compactness for the use in the built-in motor application and any other application where the assembly space is concerned. FSB50825US is the most solution for the compact inverter providing the energy efficiency, compactness, and low electromagnetic interference.

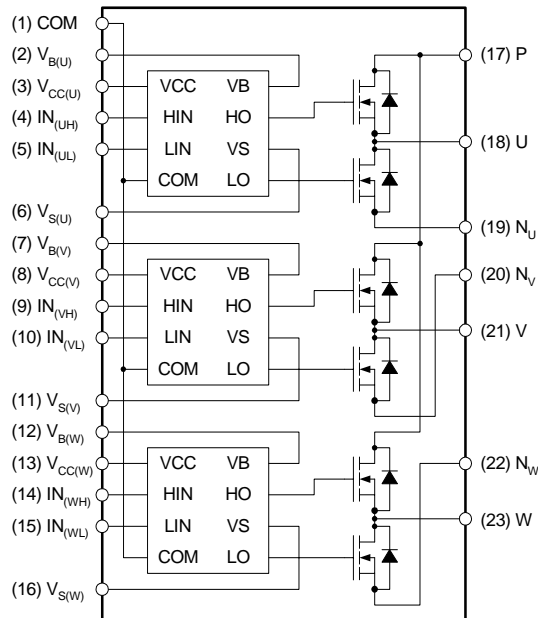


### Absolute Maximum Ratings

| Symbol          | Parameter   | Conditions   | Rating              | Units                     |
|-----------------|---|--|---------------------|---------------------------|
| $V_{PN}$        | DC Link Input Voltage, Drain-source Voltage of each FRFET |  | 250                 | V                         |
| $I_{D25}$       | Each FRFET Drain Current, Continuous                      | $T_C = 25^\circ\text{C}$                                   | 4                   | A                         |
| $I_{D125}$      | Each FRFET Drain Current, Continuous                      | $T_C = 125^\circ\text{C}$                                  | 1.6                 | A                         |
| $I_{DP}$        | Each FRFET Drain Current, Peak                            | $T_C = 25^\circ\text{C}$ , $PW < 100\mu\text{s}$           | 8                   | A                         |
| $P_D$           | Maximum Power Dissipation                                 | $T_C = 25^\circ\text{C}$ , Each FRFET                      | 14                  | W                         |
| $V_{CC}$        | Control Supply Voltage                                    | Applied between $V_{CC}$ and COM                           | 20                  | V                         |
| $V_{BS}$        | High-side Bias Voltage                                    | Applied between $V_{B(U)}-U$ , $V_{B(V)}-V$ , $V_{B(W)}-W$ | 20                  | V                         |
| $V_{IN}$        | Input Signal Voltage                                      | Applied between IN and COM                                 | -0.3 ~ $V_{CC}+0.3$ | V                         |
| $T_J$           | Operating Junction Temperature                            |  | -40 ~ 150           | $^\circ\text{C}$          |
| $T_{STG}$       | Storage Temperature                                       |  | -50 ~ 150           | $^\circ\text{C}$          |
| $R_{\theta JC}$ | Junction to Case Thermal Resistance                       | Each FRFET under inverter operating condition (Note 1)     | 8.8                 | $^\circ\text{C}/\text{W}$ |
| $V_{ISO}$       | Isolation Voltage   | 60Hz, Sinusoidal, 1 minute, Connection pins to heatsink    | 1500                | $V_{rms}$                 |

### Pin Descriptions

| Pin Number | Pin Name    | Pin Description   |
|------------|-------------|---|
| 1          | COM         | IC Common Supply Ground                                 |
| 2          | $V_{B(U)}$  | Bias Voltage for U Phase High Side FRFET Driving        |
| 3          | $V_{CC(U)}$ | Bias Voltage for U Phase IC and Low Side FRFET Driving  |
| 4          | $IN_{(UH)}$ | Signal Input for U Phase High-side                      |
| 5          | $IN_{(UL)}$ | Signal Input for U Phase Low-side                       |
| 6          | $V_{S(U)}$  | Bias Voltage Ground for U Phase High Side FRFET Driving |
| 7          | $V_{B(V)}$  | Bias Voltage for V Phase High Side FRFET Driving        |
| 8          | $V_{CC(V)}$ | Bias Voltage for V Phase IC and Low Side FRFET Driving  |
| 9          | $IN_{(VH)}$ | Signal Input for V Phase High-side                      |
| 10         | $IN_{(VL)}$ | Signal Input for V Phase Low-side                       |
| 11         | $V_{S(V)}$  | Bias Voltage Ground for V Phase High Side FRFET Driving |
| 12         | $V_{B(W)}$  | Bias Voltage for W Phase High Side FRFET Driving        |
| 13         | $V_{CC(W)}$ | Bias Voltage for W Phase IC and Low Side FRFET Driving  |
| 14         | $IN_{(WH)}$ | Signal Input for W Phase High-side                      |
| 15         | $IN_{(WL)}$ | Signal Input for W Phase Low-side                       |
| 16         | $V_{S(W)}$  | Bias Voltage Ground for W Phase High Side FRFET Driving |
| 17         | P           | Positive DC-Link Input                                  |
| 18         | U           | Output for U Phase                                      |
| 19         | $N_U$       | Negative DC-Link Input for U Phase                      |
| 20         | $N_V$       | Negative DC-Link Input for V Phase                      |
| 21         | V           | Output for V Phase                                      |
| 22         | $N_W$       | Negative DC-Link Input for W Phase                      |
| 23         | W           | Output for W Phase                                      |



**Note:**  
Source terminal of each low-side MOSFET is not connected to supply ground or bias voltage ground inside SPM®. External connections should be made as indicated in Figure 2 and 5.

**Figure 1. Pin Configuration and Internal Block Diagram (Bottom View)**

**Electrical Characteristics** ( $T_J = 25^\circ\text{C}$ ,  $V_{CC}=V_{BS}=15\text{V}$  Unless Otherwise Specified)

**Inverter Part** (Each FRFET Unless Otherwise Specified)

| Symbol                       | Parameter                                 | Conditions   | Min         | Typ  | Max  | Units         |
|------------------------------|---|--|-------------|------|------|---------------|
| $BV_{DSS}$                   | Drain-Source Breakdown Voltage            | $V_{IN}=0\text{V}$ , $I_D = 250\mu\text{A}$ (Note 2)   | 250         | -    | -    | V             |
| $\Delta BV_{DSS}/\Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\mu\text{A}$ , Referenced to $25^\circ\text{C}$  | -           | 0.31 | -    | V             |
| $I_{DSS}$                    | Zero Gate Voltage Drain Current           | $V_{IN}=0\text{V}$ , $V_{DS} = 250\text{V}$  | -           | -    | 250  | $\mu\text{A}$ |
| $R_{DS(on)}$                 | Static Drain-Source On-Resistance         | $V_{CC} = V_{BS} = 15\text{V}$ , $V_{IN} = 5\text{V}$ , $I_D = 2.0\text{A}$  | -           | -    | 0.45 | $\Omega$      |
| $V_{SD}$                     | Drain-Source Diode Forward Voltage        | $V_{CC} = V_{BS} = 15\text{V}$ , $V_{IN} = 0\text{V}$ , $I_D = -2.0\text{A}$   | -           | -    | 1.2  | V             |
| $t_{ON}$                     | Switching Times                           | $V_{PN} = 150\text{V}$ , $V_{CC} = V_{BS} = 15\text{V}$ , $I_D = 2.0\text{A}$<br>$V_{IN} = 0\text{V} \leftrightarrow 5\text{V}$<br>Inductive load $L=3\text{mH}$<br>High- and low-side FRFET switching<br><br>(Note 3) | -           | 1050 | -    | ns            |
| $t_{OFF}$                    |   |  | -           | 450  | -    | ns            |
| $t_{rr}$                     |   |  | -           | 140  | -    | ns            |
| $E_{ON}$                     |   |  | -           | 100  | -    | $\mu\text{J}$ |
| $E_{OFF}$                    |   |  | -           | 5    | -    | $\mu\text{J}$ |
| RBSOA                        | Reverse-bias Safe Operating Area          | $V_{PN} = 200\text{V}$ , $V_{CC} = V_{BS} = 15\text{V}$ , $I_D = I_{DP}$ , $V_{DS}=BV_{DSS}$ ,<br>$T_J = 150^\circ\text{C}$<br>High- and low-side FRFET switching (Note 4)   | Full Square |      |      |               |

**Control Part** (Each HVIC Unless Otherwise Specified)

| Symbol     | Parameter                                    | Conditions   | Min | Typ | Max | Units         |
|------------|--|--|-----|-----|-----|---------------|
| $I_{QCC}$  | Quiescent $V_{CC}$ Current                   | $V_{CC}=15\text{V}$ , $V_{IN}=0\text{V}$ Applied between $V_{CC}$ and COM                              | -   | -   | 160 | $\mu\text{A}$ |
| $I_{QBS}$  | Quiescent $V_{BS}$ Current                   | $V_{BS}=15\text{V}$ , $V_{IN}=0\text{V}$ Applied between $V_{B(U)}-U$ ,<br>$V_{B(V)}-V$ , $V_{B(W)}-W$ | -   | -   | 100 | $\mu\text{A}$ |
| $UV_{CCD}$ | Low-side Undervoltage Protection (Figure 6)  | $V_{CC}$ Undervoltage Protection Detection Level   | 7.4 | 8.0 | 9.4 | V             |
| $UV_{CCR}$ |  | $V_{CC}$ Undervoltage Protection Reset Level   | 8.0 | 8.9 | 9.8 | V             |
| $UV_{BSD}$ | High-side Undervoltage Protection (Figure 7) | $V_{BS}$ Undervoltage Protection Detection Level   | 7.4 | 8.0 | 9.4 | V             |
| $UV_{BSR}$ |  | $V_{BS}$ Undervoltage Protection Reset Level   | 8.0 | 8.9 | 9.8 | V             |
| $V_{IH}$   | ON Threshold Voltage                         | Logic High Level   | 3.0 | -   | -   | V             |
| $V_{IL}$   | OFF Threshold Voltage                        | Logic Low Level  |     |     |     |               |
| $I_{IH}$   | Input Bias Current                           | $V_{IN} = 5\text{V}$   | -   | 10  | 20  | $\mu\text{A}$ |
| $I_{IL}$   |  | $V_{IN} = 0\text{V}$   | -   | -   | 2   | $\mu\text{A}$ |

**Note:**

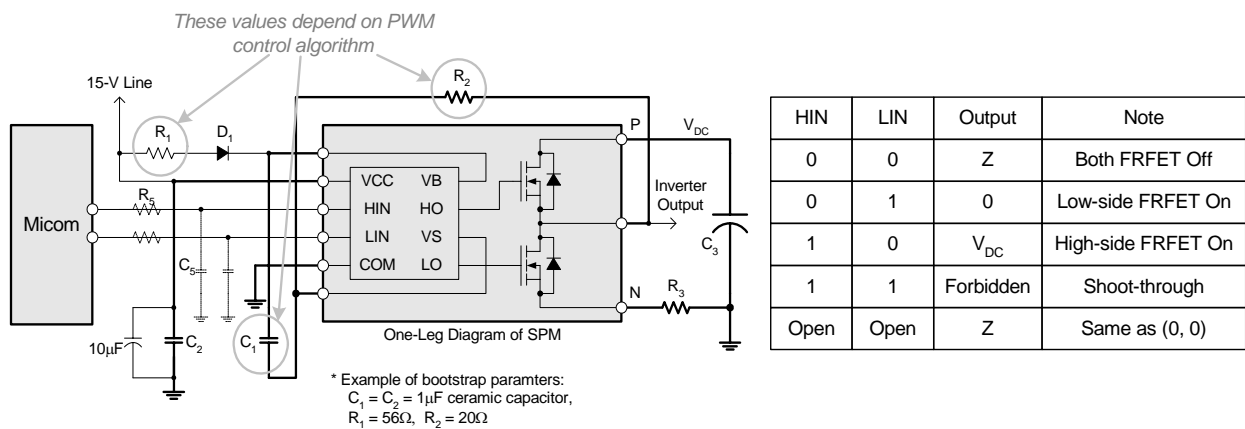
- For the measurement point of case temperature  $T_C$ , please refer to Figure 3 in page 4.
- $BV_{DSS}$  is the absolute maximum voltage rating between drain and source terminal of each FRFET inside SPM®.  $V_{PN}$  should be sufficiently less than this value considering the effect of the stray inductance so that  $V_{DS}$  should not exceed  $BV_{DSS}$  in any case.
- $t_{ON}$  and  $t_{OFF}$  include the propagation delay time of the internal drive IC. Listed values are measured at the laboratory test condition, and they can be different according to the field applications due to the effect of different printed circuit boards and wirings. Please see Figure 4 for the switching time definition with the switching test circuit of Figure 5.
- The peak current and voltage of each FRFET during the switching operation should be included in the safe operating area (SOA). Please see Figure 5 for the RBSOA test circuit that is same as the switching test circuit.

**Package Marking & Ordering Information**

| Device Marking | Device     | Package  | Reel Size | Packing Type | Quantity |
|----------------|------------|----------|-----------|--------------|----------|
| FSB50825US     | FSB50825US | SPM23-BD | 330mm     | Tape & reel  | 450      |

### Recommended Operating Conditions

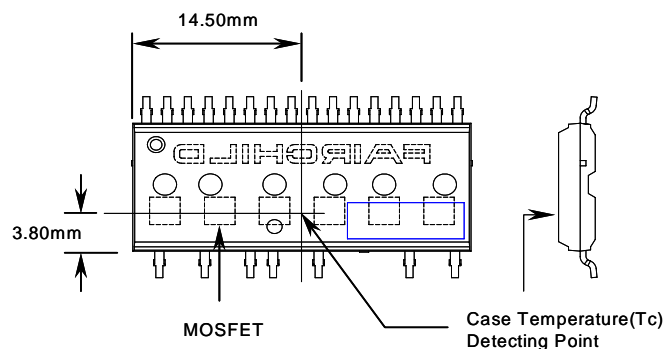
| Symbol               | Parameter                              | Conditions   | Value |      |                 | Units |
|----------------------|--|--|-------|------|-----------------|-------|
|                      |  |  | Min.  | Typ. | Max.            |       |
| V <sub>PN</sub>      | Supply Voltage                         | Applied between P and N  | -     | 150  | 200             | V     |
| V <sub>CC</sub>      | Control Supply Voltage                 | Applied between V <sub>CC</sub> and COM                                | 13.5  | 15   | 16.5            | V     |
| V <sub>BS</sub>      | High-side Bias Voltage                 | Applied between V <sub>B</sub> and output(U, V, W)                     | 13.5  | 15   | 16.5            | V     |
| V <sub>IN(ON)</sub>  | Input ON Threshold Voltage             | Applied between IN and COM   | 3.0   | -    | V <sub>CC</sub> | V     |
| V <sub>IN(OFF)</sub> | Input OFF Threshold Voltage            |  | 0     | -    | 0.6             | V     |
| t <sub>dead</sub>    | Blanking Time for Preventing Arm-short | V <sub>CC</sub> =V <sub>BS</sub> =13.5 ~ 16.5V, T <sub>J</sub> ≤ 150°C | 1.0   | -    | -               | μs    |
| f <sub>PWM</sub>     | PWM Switching Frequency                | T <sub>J</sub> ≤ 150°C   | -     | 15   | -               | kHz   |



**Note:**

- (1) It is recommended the bootstrap diode D<sub>1</sub> to have soft and fast recovery characteristics with 400-V rating
- (2) Parameters for bootstrap circuit elements are dependent on PWM algorithm. For 15 kHz of switching frequency, typical example of parameters is shown above.
- (3) RC coupling(R<sub>5</sub> and C<sub>5</sub>) at each input (indicated as dotted lines) may be used to prevent improper input signal due to surge noise. Signal input of SPM® is compatible with standard CMOS or LSTTL outputs.
- (4) Bold lines should be short and thick in PCB pattern to have small stray inductance of circuit, which results in the reduction of surge voltage. Bypass capacitors such as C<sub>1</sub>, C<sub>2</sub> and C<sub>3</sub> should have good high-frequency characteristics to absorb high-frequency ripple current.

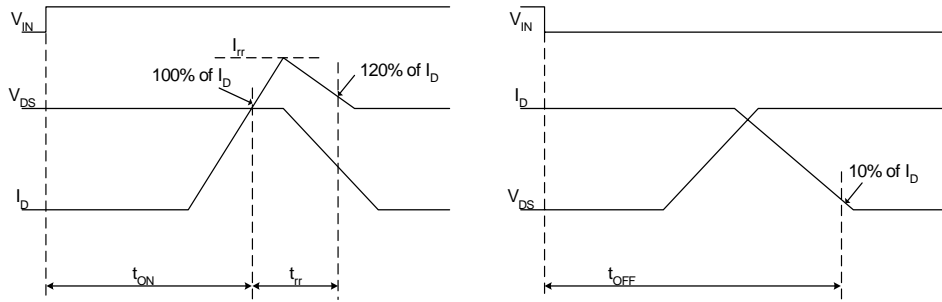
**Figure 2. Recommended CPU Interface and Bootstrap Circuit with Parameters**



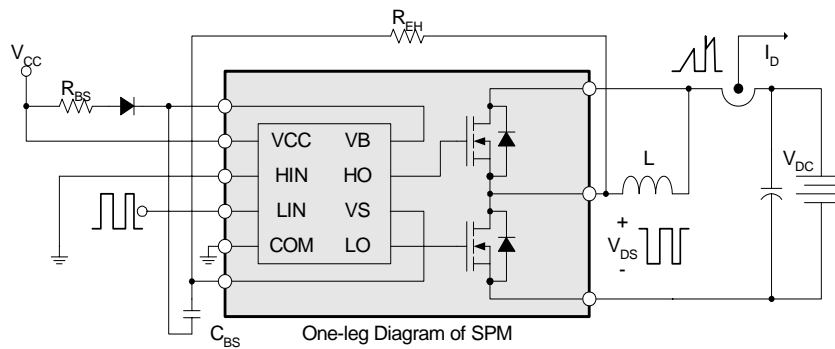
**Note:**

Attach the thermocouple on top of the heatsink-side of SPM® (between SPM® and heatsink if applied) to get the correct temperature measurement.

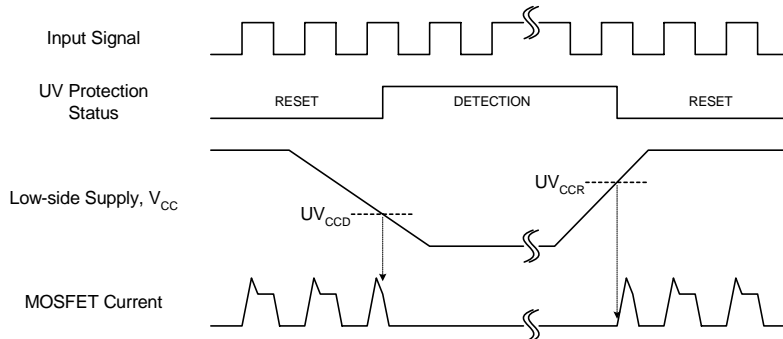
**Figure 3. Case Temperature Measurement**



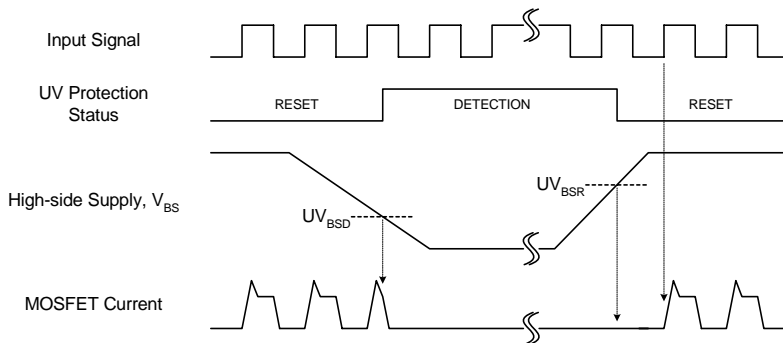
(a) Turn-on (b) Turn-off  
**Figure 4. Switching Time Definition**



**Figure 5. Switching and RBSOA(Single-pulse) Test Circuit (Low-side)**



**Figure 6. Undervoltage Protection (Low-side)**



**Figure 7. Undervoltage Protection (High-side)**

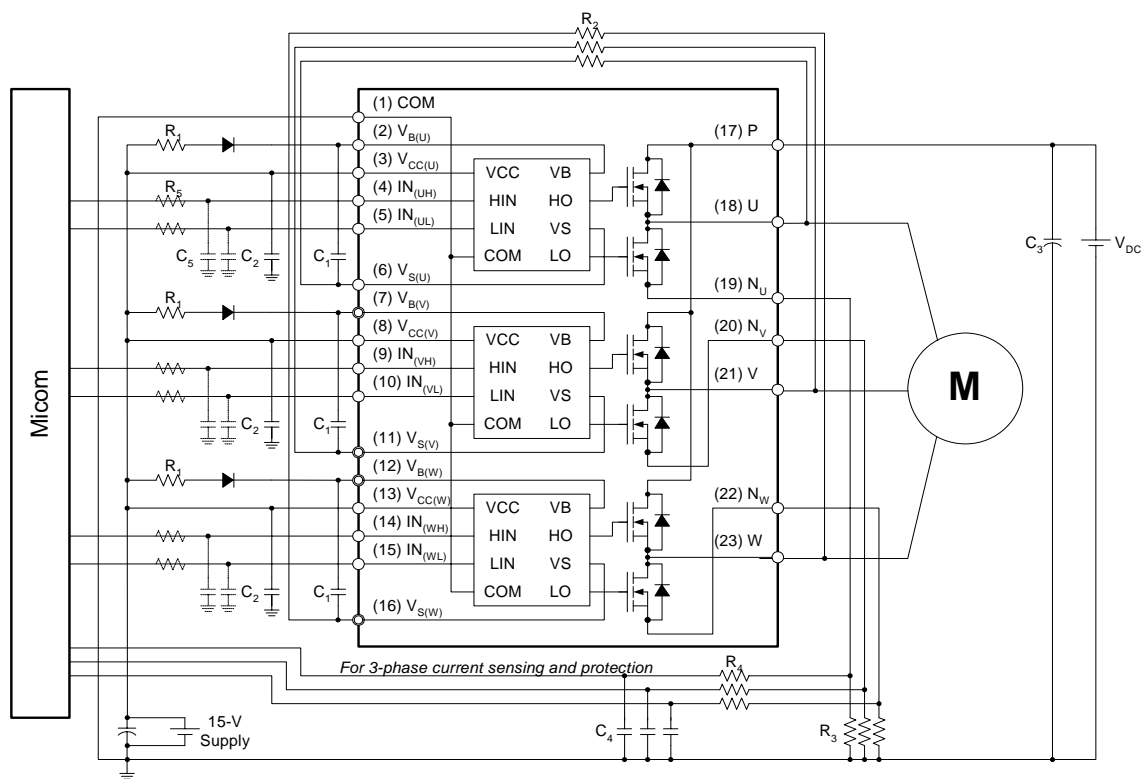
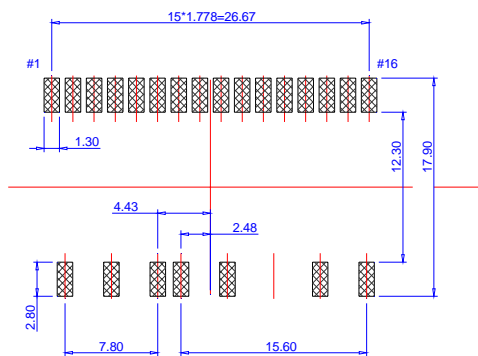
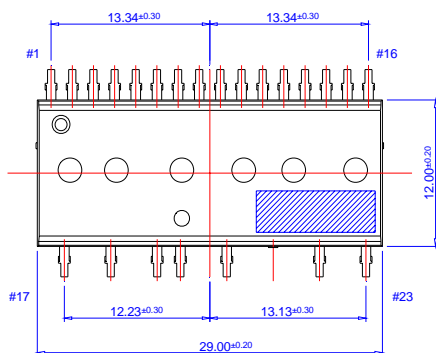
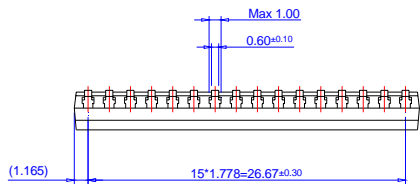
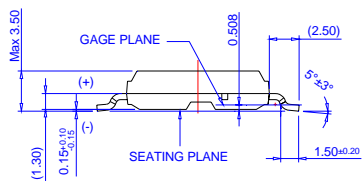
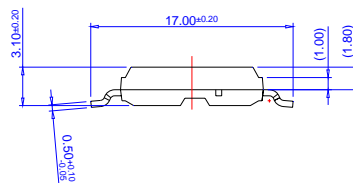
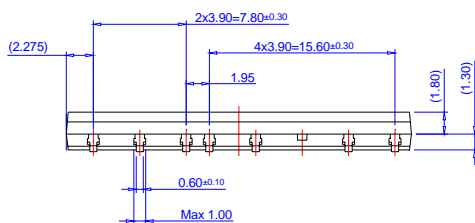


Figure 8. Example of Application Circuit

### Detailed Package Outline Drawings




LAND PATTERN RECOMMENDATIONS



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| FAST <sub>r</sub> <sup>™</sup>                   | PACMAN <sup>™</sup>             | SuperSOT <sup>™</sup> -3               |   |
| FPS <sup>™</sup>                                 | POP <sup>™</sup>                | SuperSOT <sup>™</sup> -6               |   |
| FRFET <sup>®</sup>                               | Power220 <sup>®</sup>           | SuperSOT <sup>™</sup> -8               |   |

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